

Notice of References Cited

 Application/Control No.
 10/634,351

 Applicant(s)/Patent Under
 Reexamination
 LIN ET AL.

 Examiner
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 Art Unit
 1713

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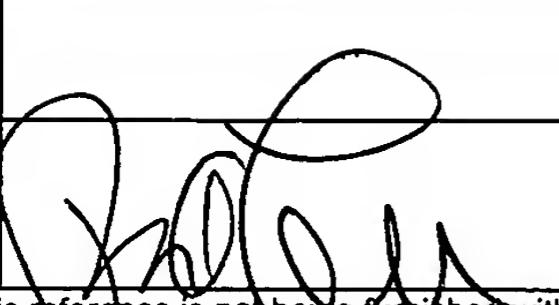
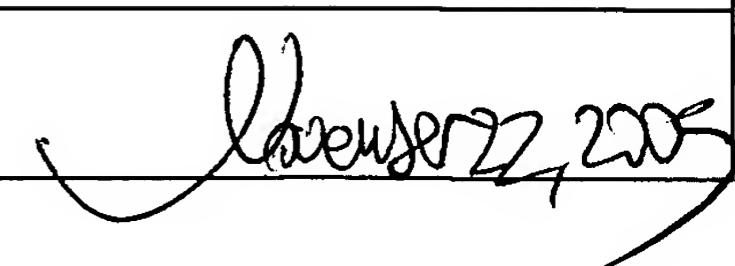
U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,240,966 A	08-1993	Iwasaki et al.	521/54
	B	US-4,693,838	09-1987	Varma et al.	508/233
	C	US-5,700,312 A	12-1997	Fausnight et al.	106/10
	D	US-5,079,287 A	01-1992	Takeshi et al.	524/528
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11-49903 A	02-1999	Japan	Sasaki et al.	C08L 23/04
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	JP 11-49903 (abstract and translation in English)
	V	
	W	
	X	 

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.